# MCP6041/2/3/4

## 600 nA, Rail-to-Rail Input/Output Op Amps

#### **Features**

- · Low Quiescent Current: 600 nA/amplifier (typical)
- Rail-to-Rail Input/Output
- Gain Bandwidth Product: 14 kHz (typical)
- Wide Supply Voltage Range: 1.4V to 6.0V
- · Unity Gain Stable
- · Available in Single, Dual, and Quad
- Chip Select (CS) with MCP6043
- · Available in 5-lead and 6-lead SOT-23 Packages
- Temperature Ranges:
  - Industrial: -40°C to +85°C
  - Extended: -40°C to +125°C

## **Applications**

- · Toll Booth Tags
- · Wearable Products
- · Temperature Measurement
- Battery Powered

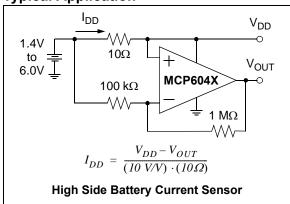
## **Design Aids**

- · SPICE Macro Models
- FilterLab<sup>®</sup> Software
- MAPS (Microchip Advanced Part Selector)
- · Analog Demonstration and Evaluation Boards
- Application Notes

## **Related Devices**

• MCP6141/2/3/4: G = +10 Stable Op Amps

## **Typical Application**



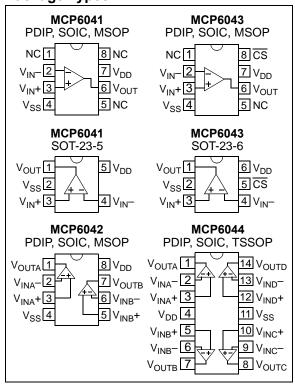
## **Description**

The MCP6041/2/3/4 family of operational amplifiers (op amps) from Microchip Technology Inc. operate with a single supply voltage as low as 1.4V, while drawing less than 1  $\mu A$  (maximum) of quiescent current per amplifier. These devices are also designed to support rail-to-rail input and output operation. This combination of features supports battery-powered and portable applications.

The MCP6041/2/3/4 amplifiers have a gain-bandwidth product of 14 kHz (typical) and are unity gain stable. These specifications make these op amps appropriate for low frequency applications, such as battery current monitoring and sensor conditioning.

The MCP6041/2/3/4 family operational amplifiers are offered in single (MCP6041), single with Chip Select  $(\overline{CS})$  (MCP6043), dual (MCP6042), and quad (MCP6044) configurations. The MCP6041 device is available in the 5-lead SOT-23 package, and the MCP6043 device is available in the 6-lead SOT-23 package.

#### **Package Types**



# 1.0 ELECTRICAL CHARACTERISTICS

## **Absolute Maximum Ratings †**

V <sub>DD</sub> – V <sub>SS</sub>	7.0V
Current at Input Pins	±2 mA
Analog Inputs (V <sub>IN</sub> +, V <sub>IN</sub> -) V <sub>SS</sub> -	- 1.0V to V <sub>DD</sub> + 1.0V
All Other Inputs and Outputs V <sub>SS</sub> -	$-0.3V$ to $V_{DD} + 0.3V$
Difference Input voltage	V <sub>DD</sub> - V <sub>SS</sub>
Output Short Circuit Current	continuous
Current at Output and Supply Pins	±30 mA
Storage Temperature	65°C to +150°C
Junction Temperature	+150°C
ESD protection on all pins (HBM; MM)	≥ 4 kV; 200V

† Notice: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

†† See Section 4.1 "Rail-to-Rail Input"

## DC ELECTRICAL CHARACTERISTICS

Parameters	Sym	Min	Тур	Max	Units	Conditions
Input Offset		<u> </u>				1
Input Offset Voltage	Vos	-3	_	+3	mV	V <sub>CM</sub> = V <sub>SS</sub>
Drift with Temperature	$\Delta V_{OS}/\Delta T_{A}$	_	±2	_	μV/°C	$V_{CM} = V_{SS}, T_{A} = -40^{\circ}\text{C to } +85^{\circ}\text{C}$
	$\Delta V_{OS}/\Delta T_{A}$	_	±15	_	μV/°C	$V_{CM} = V_{SS},$ $T_A = +85$ °C to +125°C
Power Supply Rejection	PSRR	70	85	_	dB	$V_{CM} = V_{SS}$
Input Bias Current and Impedance						•
Input Bias Current	I <sub>B</sub>	_	1	_	pА	
Industrial Temperature	I <sub>B</sub>	_	20	100	pА	T <sub>A</sub> = +85°
Extended Temperature	I <sub>B</sub>	_	1200	5000	pА	T <sub>A</sub> = +125°
Input Offset Current	los	_	1	_	pА	
Common Mode Input Impedance	Z <sub>CM</sub>	_	10 <sup>13</sup>   6	_	Ω  pF	
Differential Input Impedance	Z <sub>DIFF</sub>	_	10 <sup>13</sup>   6	_	Ω  pF	
Common Mode						
Common-Mode Input Range	$V_{CMR}$	V <sub>SS</sub> -0.3	_	V <sub>DD</sub> +0.3	V	
Common-Mode Rejection Ratio	CMRR	62	80		dB	$V_{DD} = 5V, V_{CM} = -0.3V \text{ to } 5.3V$
	CMRR	60	75		dB	$V_{DD} = 5V, V_{CM} = 2.5V \text{ to } 5.3V$
	CMRR	60	80	_	dB	$V_{DD} = 5V$ , $V_{CM} = -0.3V$ to 2.5V
Open-Loop Gain						
DC Open-Loop Gain (large signal)	A <sub>OL</sub>	95	115	_	dB	$R_L = 50 \text{ k}\Omega \text{ to V}_L,$ $V_{OUT} = 0.1 \text{V to V}_{DD} - 0.1 \text{V}$
Output						
Maximum Output Voltage Swing	V <sub>OL</sub> , V <sub>OH</sub>	V <sub>SS</sub> + 10	_	V <sub>DD</sub> – 10	mV	$R_L = 50 \text{ k}\Omega \text{ to V}_L,$ 0.5V input overdrive
Linear Region Output Voltage Swing	V <sub>OVR</sub>	V <sub>SS</sub> + 100	_	V <sub>DD</sub> – 100	mV	$R_L = 50 \text{ k}\Omega \text{ to } V_L,$ $A_{OL} \ge 95 \text{ dB}$
Output Short Circuit Current	I <sub>SC</sub>	_	2	_	mA	V <sub>DD</sub> = 1.4V
	I <sub>SC</sub>		20		mA	V <sub>DD</sub> = 5.5V
Power Supply						
Supply Voltage	V <sub>DD</sub>	1.4	_	6.0	V	(Note 1)
Quiescent Current per Amplifier	ΙQ	0.3	0.6	1.0	μA	I <sub>O</sub> = 0

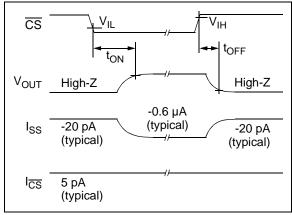
Note 1: All parts with date codes November 2007 and later have been screened to ensure operation at V<sub>DD</sub> = 6.0V. However, the other minimum and maximum specifications are measured at 1.4V and/or 5.5V.

## **AC ELECTRICAL CHARACTERISTICS**

<b>Electrical Characteristics:</b> Unless otherwise indicated, $V_{DD} = +1.4V$ to $+5.5V$ , $V_{SS} = GND$ , $T_A = 25^{\circ}C$ , $V_{CM} = V_{DD}/2$ , $V_{OUT} \approx V_{DD}/2$ , $V_L = V_{$								
Parameters	Sym	Min	Тур	Max	Units	Conditions		
AC Response								
Gain Bandwidth Product	GBWP	_	14	_	kHz			
Slew Rate	SR	_	3.0	_	V/ms			
Phase Margin	PM	_	65	_	0	G = +1 V/V		
Noise	<u>.</u>							
Input Voltage Noise	E <sub>ni</sub>	_	5.0	_	μV <sub>P-P</sub>	f = 0.1 Hz to 10 Hz		
Input Voltage Noise Density	e <sub>ni</sub>	_	170	_	nV/√Hz	f = 1 kHz		
Input Current Noise Density	i <sub>ni</sub>	_	0.6	_	fA/√Hz	f = 1 kHz		

## MCP6043 CHIP SELECT (CS) ELECTRICAL CHARACTERISTICS

<b>Electrical Characteristics:</b> Unless otherwise indicated, $V_{DD}$ = +1.4V to +5.5V, $V_{SS}$ = GND, $T_A$ = 25°C, $V_{CM}$ = $V_{DD}/2$ , $V_{OUT} \approx V_{DD}/2$ , $V_L = V_{DD}/2$									
Parameters	Sym	Min	Тур	Max	Units	Conditions			
CS Low Specifications									
CS Logic Threshold, Low	$V_{IL}$	V <sub>SS</sub>	_	V <sub>SS</sub> +0.3	V				
CS Input Current, Low	I <sub>CSL</sub>	_	5	_	рА	CS = V <sub>SS</sub>			
CS High Specifications									
CS Logic Threshold, High	$V_{IH}$	V <sub>DD</sub> -0.3	_	V <sub>DD</sub>	V				
CS Input Current, High	I <sub>CSH</sub>	_	5	_	рА	$\overline{\text{CS}} = V_{\text{DD}}$			
CS Input High, GND Current	I <sub>SS</sub>	_	-20	_	рА	$\overline{\text{CS}} = V_{\text{DD}}$			
Amplifier Output Leakage, CS High	I <sub>OLEAK</sub>	_	20	_	рА	$\overline{\text{CS}} = V_{\text{DD}}$			
Dynamic Specifications									
CS Low to Amplifier Output Turn-on Time	t <sub>ON</sub>	_	2	50	ms	$G = +1V/V$ , $\overline{CS} = 0.3V$ to $V_{OUT} = 0.9V_{DD}/2$			
CS High to Amplifier Output High-Z	t <sub>OFF</sub>	_	10	_	μs	G = +1V/V, $\overline{\text{CS}}$ = V <sub>DD</sub> -0.3V to V <sub>OUT</sub> = 0.1V <sub>DD</sub> /2			
Hysteresis	V <sub>HYST</sub>	_	0.6	_	V	V <sub>DD</sub> = 5.0V			



**FIGURE 1-1:** Chip Select  $(\overline{CS})$  Timing Diagram (MCP6043 only).

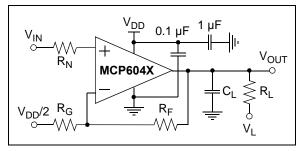
#### TEMPERATURE CHARACTERISTICS

Parameters	Sym	Min	Тур	Max	Units	Conditions		
Temperature Ranges								
Specified Temperature Range	T <sub>A</sub>	-40	_	+85	°C	Industrial Temperature parts		
	T <sub>A</sub>	-40	_	+125	°C	Extended Temperature parts		
Operating Temperature Range	T <sub>A</sub>	-40	_	+125	°C	(Note 1)		
Storage Temperature Range	T <sub>A</sub>	-65	_	+150	°C			
Thermal Package Resistances								
Thermal Resistance, 5L-SOT-23	$\theta_{JA}$	_	256	_	°C/W			
Thermal Resistance, 6L-SOT-23	$\theta_{JA}$		230	_	°C/W			
Thermal Resistance, 8L-PDIP	$\theta_{JA}$	_	85	_	°C/W			
Thermal Resistance, 8L-SOIC	$\theta_{JA}$	_	163	_	°C/W			
Thermal Resistance, 8L-MSOP	$\theta_{JA}$		206	_	°C/W			
Thermal Resistance, 14L-PDIP	$\theta_{JA}$	_	70	_	°C/W			
Thermal Resistance, 14L-SOIC	$\theta_{JA}$		120	_	°C/W			
Thermal Resistance, 14L-TSSOP	$\theta_{JA}$	_	100	_	°C/W			

Note 1: The MCP6041/2/3/4 family of Industrial Temperature op amps operates over this extended range, but with reduced performance. In any case, the internal Junction Temperature (T<sub>J</sub>) must not exceed the Absolute Maximum specification of +150°C.

## 1.1 Test Circuits

The test circuits used for the DC and AC tests are shown in Figure 1-2 and Figure 1-3. The bypass capacitors are laid out according to the rules discussed in **Section 4.6 "Supply Bypass"**.



**FIGURE 1-2:** AC and DC Test Circuit for Most Non-Inverting Gain Conditions.

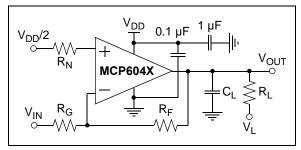


FIGURE 1-3: AC and DC Test Circuit for Most Inverting Gain Conditions.

## 2.0 TYPICAL PERFORMANCE CURVES

**Note:** The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

**Note:** Unless otherwise indicated,  $T_A = +25^{\circ}C$ ,  $V_{DD} = +1.4V$  to +6.0V,  $V_{SS} = GND$ ,  $V_{CM} = V_{DD}/2$ ,  $V_{OUT} \approx V_{DD}/2$ ,  $V_L = V_{DD}/2$ ,  $R_L = 1$  M $\Omega$  to  $V_L$ , and  $C_L = 60$  pF.

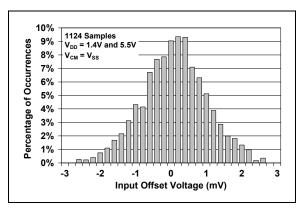
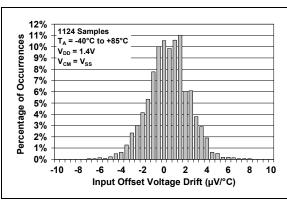
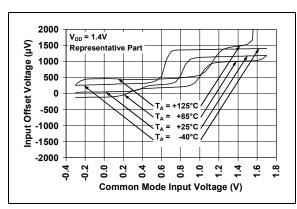


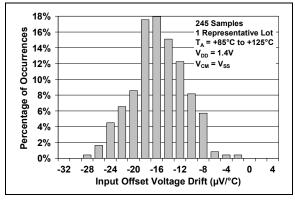
FIGURE 2-1: Input Offset Voltage.



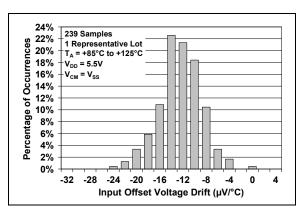
**FIGURE 2-2:** Input Offset Voltage Drift with  $T_A = -40$ °C to +85°C.



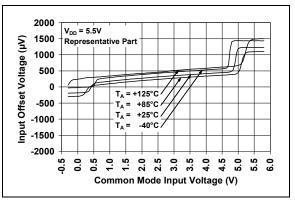
**FIGURE 2-3:** Input Offset Voltage vs. Common Mode Input Voltage with  $V_{DD} = 1.4V$ .



**FIGURE 2-4:** Input Offset Voltage Drift with  $T_A = +85$ °C to +125°C and  $V_{DD} = 1.4$ V.



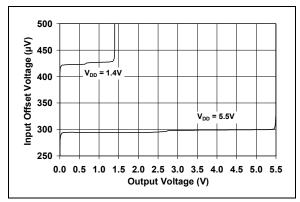
**FIGURE 2-5:** Input Offset Voltage Drift with  $T_A = +25$ °C to +125°C and  $V_{DD} = 5.5$ V.



**FIGURE 2-6:** Input Offset Voltage vs. Common Mode Input Voltage with  $V_{DD} = 5.5V$ .

## MCP6041/2/3/4

**Note:** Unless otherwise indicated,  $T_A$  = +25°C,  $V_{DD}$  = +1.4V to +6.0V,  $V_{SS}$  = GND,  $V_{CM}$  =  $V_{DD}/2$ ,  $V_{OUT} \approx V_{DD}/2$ ,  $V_L$  =  $V_{DD}/2$ ,  $R_L$  = 1 M $\Omega$  to  $V_L$ , and  $C_L$  = 60 pF.



**FIGURE 2-7:** Input Offset Voltage vs. Output Voltage.

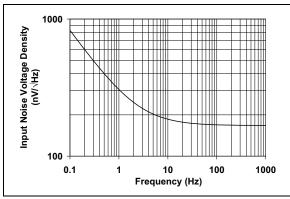


FIGURE 2-8: Input Noise Voltage Density vs. Frequency.

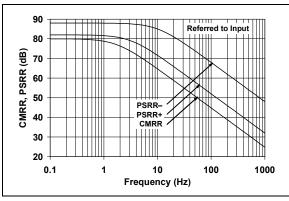
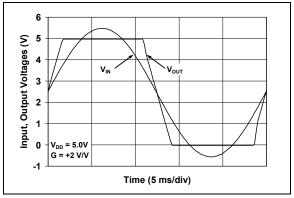
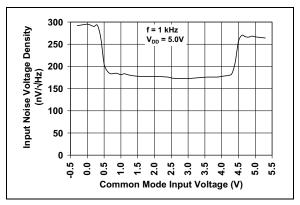


FIGURE 2-9: CMRR, PSRR vs. Frequency.



**FIGURE 2-10:** The MCP6041/2/3/4 family shows no phase reversal.



**FIGURE 2-11:** Input Noise Voltage Density vs. Common Mode Input Voltage.

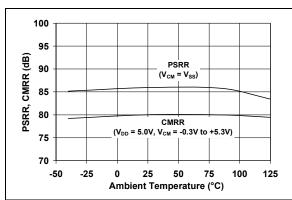
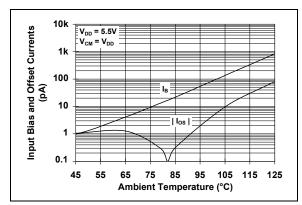
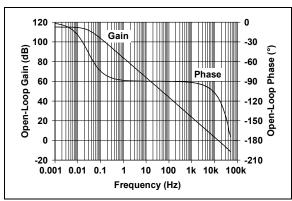


FIGURE 2-12: CMRR, PSRR vs. Ambient Temperature.

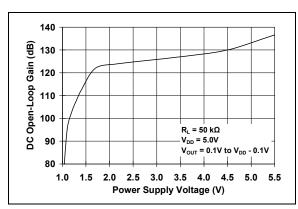
**Note:** Unless otherwise indicated,  $T_A = +25^{\circ}C$ ,  $V_{DD} = +1.4V$  to +6.0V,  $V_{SS} = GND$ ,  $V_{CM} = V_{DD}/2$ ,  $V_{OUT} \approx V_{DD}/2$ ,  $V_L = V_{DD}/2$ ,  $R_L = 1$  M $\Omega$  to  $V_L$ , and  $C_L = 60$  pF.



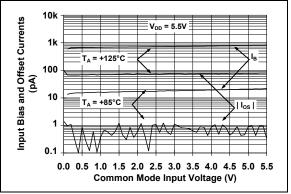
**FIGURE 2-13:** Input Bias, Offset Currents vs. Ambient Temperature.



**FIGURE 2-14:** Open-Loop Gain, Phase vs. Frequency.



**FIGURE 2-15:** DC Open-Loop Gain vs. Power Supply Voltage.



**FIGURE 2-16:** Input Bias, Offset Currents vs. Common Mode Input Voltage.

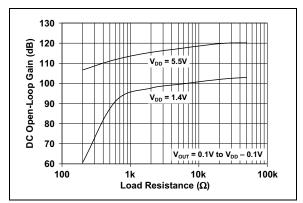
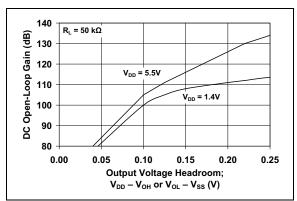


FIGURE 2-17: DC Open-Loop Gain vs. Load Resistance.



**FIGURE 2-18:** DC Open-Loop Gain vs. Output Voltage Headroom.

**Note:** Unless otherwise indicated,  $T_A = +25^{\circ}C$ ,  $V_{DD} = +1.4V$  to +6.0V,  $V_{SS} = GND$ ,  $V_{CM} = V_{DD}/2$ ,  $V_{OUT} \approx V_{DD}/2$ ,  $V_L = V_{DD}/2$ ,  $R_L = 1$  M $\Omega$  to  $V_L$ , and  $C_L = 60$  pF.

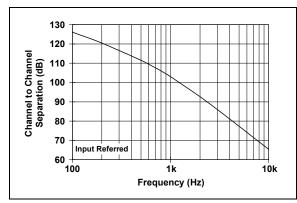
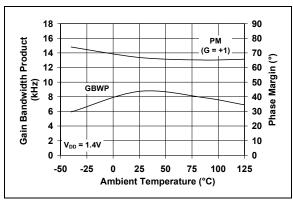
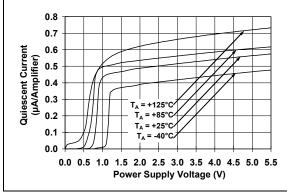


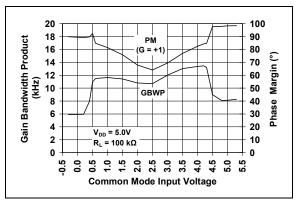
FIGURE 2-19: Channel-to-Channel Separation vs. Frequency (MCP6042 and MCP6044 only).



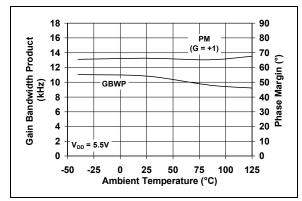
**FIGURE 2-20:** Gain Bandwidth Product, Phase Margin vs. Ambient Temperature with  $V_{DD} = 1.4V$ .



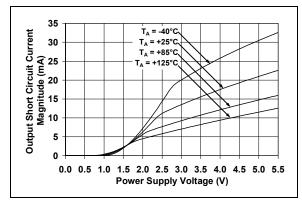
**FIGURE 2-21:** Quiescent Current vs. Power Supply Voltage.



**FIGURE 2-22:** Gain Bandwidth Product, Phase Margin vs. Common Mode Input Voltage.

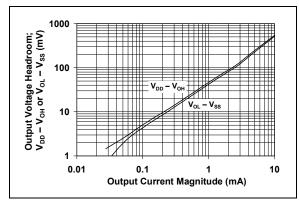


**FIGURE 2-23:** Gain Bandwidth Product, Phase Margin vs. Ambient Temperature with  $V_{DD} = 5.5V$ .

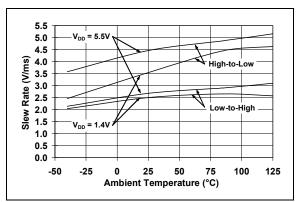


**FIGURE 2-24:** Output Short Circuit Current vs. Power Supply Voltage.

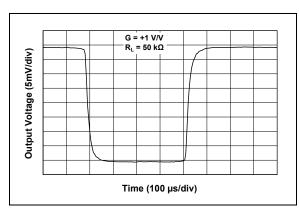
**Note:** Unless otherwise indicated,  $T_A$  = +25°C,  $V_{DD}$  = +1.4V to +6.0V,  $V_{SS}$  = GND,  $V_{CM}$  =  $V_{DD}/2$ ,  $V_{OUT} \approx V_{DD}/2$ ,  $V_L$  =  $V_{DD}/2$ ,  $R_L$  = 1 M $\Omega$  to  $V_L$ , and  $C_L$  = 60 pF.



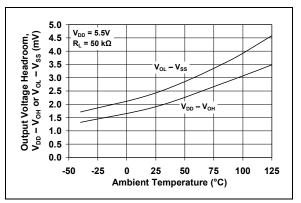
**FIGURE 2-25:** Output Voltage Headroom vs. Output Current Magnitude.



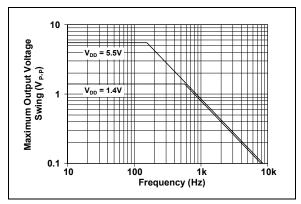
**FIGURE 2-26:** Slew Rate vs. Ambient Temperature.



**FIGURE 2-27:** Small Signal Non-inverting Pulse Response.



**FIGURE 2-28:** Output Voltage Headroom vs. Ambient Temperature.



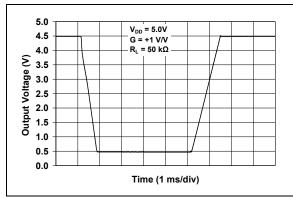
**FIGURE 2-29:** Maximum Output Voltage Swing vs. Frequency.



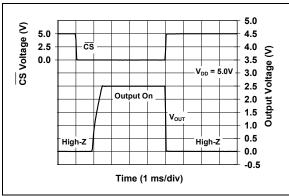
FIGURE 2-30: Small Signal Inverting Pulse Response.

## MCP6041/2/3/4

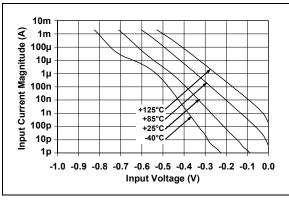
**Note:** Unless otherwise indicated,  $T_A$  = +25°C,  $V_{DD}$  = +1.4V to +6.0V,  $V_{SS}$  = GND,  $V_{CM}$  =  $V_{DD}/2$ ,  $V_{OUT} \approx V_{DD}/2$ ,  $V_L$  =  $V_{DD}/2$ ,  $R_L$  = 1 M $\Omega$  to  $V_L$ , and  $C_L$  = 60 pF.



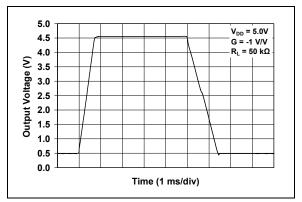
**FIGURE 2-31:** Large Signal Non-inverting Pulse Response.



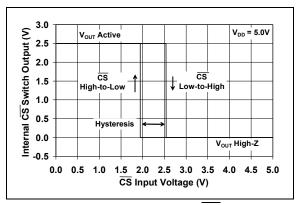
**FIGURE 2-32:** Chip Select  $(\overline{CS})$  to Amplifier Output Response Time (MCP6043 only).



**FIGURE 2-33:** Input Current vs. Input Voltage (below  $V_{SS}$ ).



**FIGURE 2-34:** Large Signal Inverting Pulse Response.



**FIGURE 2-35:** Chip Select  $(\overline{CS})$  Hysteresis (MCP6043 only).

## 3.0 PIN DESCRIPTIONS

Descriptions of the pins are listed in Table 3-1.

TABLE 3-1: PIN FUNCTION TABLE

МС	CP6041	MCP6042	М	CP6043	MCP6044		
PDIP, SOIC, MSOP	SOT-23-5	PDIP, SOIC, MSOP	PDIP, SOIC, MSOP	SOT-23-6	PDIP, SOIC, TSSOP	Symbol	Description
6	1	1	6	1	1	V <sub>OUT</sub> , V <sub>OUTA</sub>	Analog Output (op amp A)
2	4	2	2	4	2	V <sub>IN</sub> -, V <sub>INA</sub> -	Inverting Input (op amp A)
3	3	3	3	3	3	V <sub>IN</sub> +, V <sub>INA</sub> +	Non-inverting Input (op amp A)
7	5	8	7	6	4	$V_{DD}$	Positive Power Supply
_	_	5	_	_	5	V <sub>INB</sub> +	Non-inverting Input (op amp B)
_	_	6	_	_	6	V <sub>INB</sub> -	Inverting Input (op amp B)
_	_	7	_	_	7	V <sub>OUTB</sub>	Analog Output (op amp B)
_	_	_	_	_	8	V <sub>OUTC</sub>	Analog Output (op amp C)
_	_	_	_	_	9	V <sub>INC</sub> -	Inverting Input (op amp C)
_	_	_	_	_	10	V <sub>INC</sub> +	Non-inverting Input (op amp C)
4	2	4	4	2	11	V <sub>SS</sub>	Negative Power Supply
_	_	_	_	_	12	V <sub>IND</sub> +	Non-inverting Input (op amp D)
_	_	_	_	_	13	V <sub>IND</sub> -	Inverting Input (op amp D)
		_			14	V <sub>OUTD</sub>	Analog Output (op amp D)
_	_	_	8	5	_	CS	Chip Select
1, 5, 8	_	_	1, 5	_	_	NC	No Internal Connection

## 3.1 Analog Outputs

The output pins are low-impedance voltage sources.

## 3.2 Analog Inputs

The non-inverting and inverting inputs are high-impedance CMOS inputs with low bias currents.

## 3.3 Chip Select Digital Input

This is a CMOS, Schmitt-triggered input that places the part into a low power mode of operation.

## 3.4 Power Supply Pins

The positive power supply pin ( $V_{DD}$ ) is 1.4V to 6.0V higher than the negative power supply pin ( $V_{SS}$ ). For normal operation, the other pins are at voltages between  $V_{SS}$  and  $V_{DD}$ .

Typically, these parts are used in a single (positive) supply configuration. In this case,  $V_{SS}$  is connected to ground and  $V_{DD}$  is connected to the supply.  $V_{DD}$  will need bypass capacitors.

## 4.0 APPLICATIONS INFORMATION

The MCP6041/2/3/4 family of op amps is manufactured using Microchip's state of the art CMOS process. These op amps are unity gain stable and suitable for a wide range of general purpose, low-power applications.

See Microchip's related MCP6141/2/3/4 family of op amps for applications, at a gain of 10 V/V or higher, needing greater bandwidth.

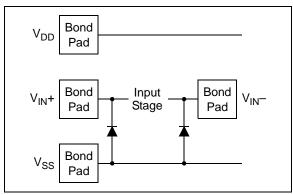
## 4.1 Rail-to-Rail Input

#### 4.1.1 PHASE REVERSAL

The MCP6041/2/3/4 op amps are designed to not exhibit phase inversion when the input pins exceed the supply voltages. Figure 2-10 shows an input voltage exceeding both supplies with no phase inversion.

# 4.1.2 INPUT VOLTAGE AND CURRENT LIMITS

The ESD protection on the inputs can be depicted as shown in Figure 4-1. This structure was chosen to protect the input transistors, and to minimize input bias current (I<sub>B</sub>). The input ESD diodes clamp the inputs when they try to go more than one diode drop below V<sub>SS</sub>. They also clamp any voltages that go too far above V<sub>DD</sub>; their breakdown voltage is high enough to allow normal operation, and low enough to bypass quick ESD events within the specified limits.



**FIGURE 4-1:** Simplified Analog Input ESD Structures.

In order to prevent damage and/or improper operation of these amplifiers, the circuit must limit the currents (and voltages) at the input pins (see Absolute Maximum Ratings † at the beginning of Section 1.0 "Electrical Characteristics"). Figure 4-2 shows the recommended approach to protecting these inputs. The internal ESD diodes prevent the input pins ( $V_{IN}$ + and  $V_{IN}$ –) from going too far below ground, and the resistors  $R_1$  and  $R_2$  limit the possible current drawn out of the input pins. Diodes  $D_1$  and  $D_2$  prevent the input pins ( $V_{IN}$ + and  $V_{IN}$ –) from going too far above  $V_{DD}$ , and

dump any currents onto  $V_{DD}$ . When implemented as shown, resistors  $R_1$  and  $R_2$  also limit the current through  $D_1$  and  $D_2$ .

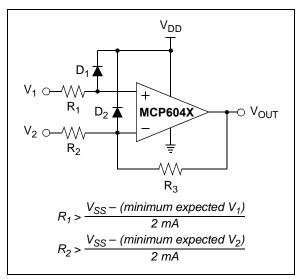


FIGURE 4-2: Protecting the Analog Inputs.

It is also possible to connect the diodes to the left of the resistor  $R_1$  and  $R_2.$  In this case, the currents through the diodes  $D_1$  and  $D_2$  need to be limited by some other mechanism. The resistors then serve as in-rush current limiters; the DC current into the input pins (V $_{\rm IN}+$  and V $_{\rm IN}-$ ) should be very small.

A significant amount of current can flow out of the inputs (through the ESD diodes) when the common mode voltage ( $V_{CM}$ ) is below ground ( $V_{SS}$ ); see Figure 2-33. Applications that are high impedance may need to limit the useable voltage range.

## 4.1.3 NORMAL OPERATION

The input stage of the MCP6041/2/3/4 op amps uses two differential input stages in parallel. One operates at a low common mode input voltage (V<sub>CM</sub>), while the other operates at a high V<sub>CM</sub>. With this topology, the device operates with a V<sub>CM</sub> up to 300 mV above V<sub>DD</sub> and 300 mV below V<sub>SS</sub>. The input offset voltage is measured at V<sub>CM</sub> = V<sub>SS</sub> – 0.3V and V<sub>DD</sub> + 0.3V to ensure proper operation.

There are two transitions in input behavior as  $V_{CM}$  is changed. The first occurs, when  $V_{CM}$  is near  $V_{SS}$  + 0.4V, and the second occurs when  $V_{CM}$  is near  $V_{DD}$  – 0.5V (see Figure 2-3 and Figure 2-6). For the best distortion performance with non-inverting gains, avoid these regions of operation.

## 4.2 Rail-to-Rail Output

There are two specifications that describe the output swing capability of the MCP6041/2/3/4 family of op amps. The first specification (Maximum Output Voltage Swing) defines the absolute maximum swing that can be achieved under the specified load condition. Thus, the output voltage swings to within 10 mV of either supply rail with a 50 k $\Omega$  load to V<sub>DD</sub>/2. Figure 2-10 shows how the output voltage is limited when the input goes beyond the linear region of operation.

The second specification that describes the output swing capability of these amplifiers is the Linear Output Voltage Range. This specification defines the maximum output swing that can be achieved while the amplifier still operates in its linear region. To verify linear operation in this range, the large signal DC Open-Loop Gain ( $A_{OL}$ ) is measured at points inside the supply rails. The measurement must meet the specified  $A_{OL}$  condition in the specification table.

## 4.3 Output Loads and Battery Life

The MCP6041/2/3/4 op amp family has outstanding quiescent current, which supports battery-powered applications. There is minimal quiescent current glitching when Chip Select (CS) is raised or lowered. This prevents excessive current draw, and reduced battery life, when the part is turned off or on.

Heavy resistive loads at the output can cause excessive battery drain. Driving a DC voltage of 2.5V across a 100 k $\Omega$  load resistor will cause the supply current to increase by 25  $\mu$ A, depleting the battery 43 times as fast as I $_{\Omega}$  (0.6  $\mu$ A, typical) alone.

High frequency signals (fast edge rate) across capacitive loads will also significantly increase supply current. For instance, a 0.1  $\mu F$  capacitor at the output presents an AC impedance of 15.9 k $\Omega$  (1/2 $\pi fC$ ) to a 100 Hz sinewave. It can be shown that the average power drawn from the battery by a 5.0  $V_{p-p}$  sinewave (1.77  $V_{rms}$ ), under these conditions, is

#### **EQUATION 4-1:**

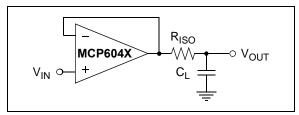
$$\begin{split} P_{Supply} &= (V_{DD} \cdot V_{SS}) \, (I_Q + V_{L(p \cdot p)} f \, C_L) \\ &= (5V) (0.6 \, \mu A + 5.0 V_{p \cdot p} \cdot 100 Hz \cdot 0.1 \mu F) \\ &= 3.0 \, \mu W + 50 \, \mu W \end{split}$$

This will drain the battery 18 times as fast as I<sub>Q</sub> alone.

#### 4.4 Capacitive Loads

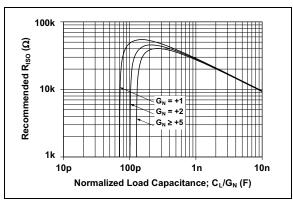
Driving large capacitive loads can cause stability problems for voltage feedback op amps. As the load capacitance increases, the feedback loop's phase margin decreases and the closed-loop bandwidth is reduced. This produces gain peaking in the frequency response, with overshoot and ringing in the step response. A unity gain buffer (G=+1) is the most sensitive to capacitive loads, although all gains show the same general behavior.

When driving large capacitive loads with these op amps (e.g.,  $> 60 \, \text{pF}$  when G = +1), a small series resistor at the output (R<sub>ISO</sub> in Figure 4-3) improves the feedback loop's phase margin (stability) by making the output load resistive at higher frequencies. The bandwidth will be generally lower than the bandwidth with no capacitive load.



**FIGURE 4-3:** Output Resistor, R<sub>ISO</sub> Stabilizes Large Capacitive Loads.

Figure 4-4 gives recommended  $R_{ISO}$  values for different capacitive loads and gains. The x-axis is the normalized load capacitance ( $C_L/G_N$ ), where  $G_N$  is the circuit's noise gain. For non-inverting gains,  $G_N$  and the Signal Gain are equal. For inverting gains,  $G_N$  is 1+|Signal Gain| (e.g., -1 V/V gives  $G_N$  = +2 V/V).



**FIGURE 4-4:** Recommended R<sub>ISO</sub> Values for Capacitive Loads.

After selecting  $R_{\rm ISO}$  for your circuit, double check the resulting frequency response peaking and step response overshoot. Modify  $R_{\rm ISO}$ 's value until the response is reasonable. Bench evaluation and simulations with the MCP6041/2/3/4 SPICE macro model are helpful.

#### 4.5 MCP6043 Chip Select

The MCP6043 is a single op amp with Chip Select ( $\overline{\text{CS}}$ ). When  $\overline{\text{CS}}$  is pulled high, the supply current drops to 50 nA (typical) and flows through the  $\overline{\text{CS}}$  pin to V<sub>SS</sub>. When this happens, the amplifier output is put into a high impedance state. By pulling  $\overline{\text{CS}}$  low, the amplifier is enabled. If the  $\overline{\text{CS}}$  pin is left floating, the amplifier may not operate properly. Figure 1-1 shows the output voltage and supply current response to a  $\overline{\text{CS}}$  pulse.

## 4.6 Supply Bypass

With this family of operational amplifiers, the power supply pin (V<sub>DD</sub> for single supply) should have a local bypass capacitor (i.e., 0.01  $\mu\text{F}$  to 0.1  $\mu\text{F}$ ) within 2 mm for good high frequency performance. It can use a bulk capacitor (i.e., 1  $\mu\text{F}$  or larger) within 100 mm to provide large, slow currents. This bulk capacitor is not required for most applications and can be shared with nearby analog parts.

## 4.7 Unused Op Amps

An unused op amp in a quad package (MCP6044) should be configured as shown in Figure 4-5. These circuits prevent the output from toggling and causing crosstalk. Circuit A sets the op amp at its minimum noise gain. The resistor divider produces any desired reference voltage within the output voltage range of the op amp; the op amp buffers that reference voltage. Circuit B uses the minimum number of components and operates as a comparator, but it may draw more current.

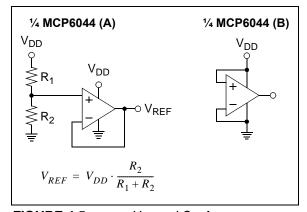
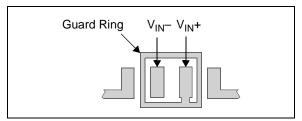


FIGURE 4-5: Unused Op Amps.

#### 4.8 PCB Surface Leakage

In applications where low input bias current is critical, printed circuit board (PCB) surface leakage effects need to be considered. Surface leakage is caused by humidity, dust or other contamination on the board. Under low humidity conditions, a typical resistance between nearby traces is  $10^{12}\Omega$ . A 5V difference would cause 5 pA of current to flow, which is greater than the MCP6041/2/3/4 family's bias current at +25°C (1 pA, typical).

The easiest way to reduce surface leakage is to use a guard ring around sensitive pins (or traces). The guard ring is biased at the same voltage as the sensitive pin. Figure 4-6 shows an example of this type of layout.



**FIGURE 4-6:** Example Guard Ring Layout for Inverting Gain.

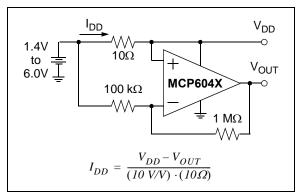
- 1. Non-inverting Gain and Unity Gain Buffer:
  - Connect the non-inverting pin (V<sub>IN</sub>+) to the input with a wire that does not touch the PCB surface.
  - b) Connect the guard ring to the inverting input pin (V<sub>IN</sub>-). This biases the guard ring to the common mode input voltage.
- Inverting Gain and Transimpedance Gain (convert current to voltage, such as photo detectors) amplifiers:
  - a) Connect the guard ring to the non-inverting input pin (V<sub>IN</sub>+). This biases the guard ring to the same reference voltage as the op amp (e.g., V<sub>DD</sub>/2 or ground).
  - b) Connect the inverting pin (V<sub>IN</sub>-) to the input with a wire that does not touch the PCB surface.

## 4.9 Application Circuits

#### 4.9.1 BATTERY CURRENT SENSING

The MCP6041/2/3/4 op amps' Common Mode Input Range, which goes 0.3V beyond both supply rails, supports their use in high-side and low-side battery current sensing applications. The very low quiescent current (0.6  $\mu$ A, typical) helps prolong battery life, and the rail-to-rail output supports detection low currents.

Figure 4-7 shows a high-side battery current sensor circuit. The  $10\Omega$  resistor is sized to minimize power losses. The battery current (I\_DD) through the  $10\Omega$  resistor causes its top terminal to be more negative than the bottom terminal. This keeps the Common mode input voltage of the op amp below V\_DD, which is within its allowed range. The output of the op amp will also be below V\_DD, which is within its Maximum Output Voltage Swing specification.



**FIGURE 4-7:** High-Side Battery Current Sensor.

#### 4.9.2 INSTRUMENTATION AMPLIFIER

The MCP6041/2/3/4 op amp is well suited for conditioning sensor signals in battery-powered applications. Figure 4-8 shows a two op amp instrumentation amplifier, using the MCP6042, that works well for applications requiring rejection of Common mode noise at higher gains. The reference voltage ( $V_{REF}$ ) is supplied by a low impedance source. In single supply applications,  $V_{REF}$  is typically  $V_{DD}/2$ .

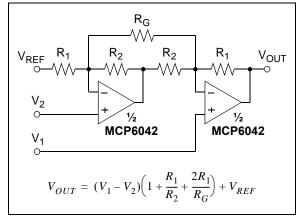


FIGURE 4-8: Two Op Amp Instrumentation Amplifier.

## 5.0 DESIGN AIDS

Microchip provides the basic design tools needed for the MCP6041/2/3/4 family of op amps.

#### 5.1 SPICE Macro Model

The latest SPICE macro model for the MCP6041/2/3/4 op amps is available on the Microchip web site at www.microchip.com. This model is intended to be an initial design tool that works well in the op amp's linear region of operation over the temperature range. See the model file for information on its capabilities.

Bench testing is a very important part of any design and cannot be replaced with simulations. Also, simulation results using this macro model need to be validated by comparing them to the data sheet specifications and characteristic curves.

## 5.2 FilterLab<sup>®</sup> Software

Microchip's FilterLab<sup>®</sup> software is an innovative software tool that simplifies analog active filter (using op amps) design. Available at no cost from the Microchip web site at <a href="https://www.microchip.com/filterlab">www.microchip.com/filterlab</a>, the FilterLab design tool provides full schematic diagrams of the filter circuit with component values. It also outputs the filter circuit in SPICE format, which can be used with the macro model to simulate actual filter performance.

# 5.3 MAPS (Microchip Advanced Part Selector)

MAPS is a software tool that helps semiconductor professionals efficiently identify Microchip devices that fit a particular design requirement. Available at no cost from the Microchip website at <a href="https://www.microchip.com/maps">www.microchip.com/maps</a>, the MAPS is an overall selection tool for Microchip's product portfolio that includes Analog, Memory, MCUs and DSCs. Using this tool you can define a filter to sort features for a parametric search of devices and export side-by-side technical comparison reports. Helpful links are also provided for data sheets, purchase, and sampling of Microchip parts.

# 5.4 Analog Demonstration and Evaluation Boards

Microchip offers a broad spectrum of Analog Demonstration and Evaluation Boards that are designed to help you achieve faster time to market. For a complete listing of these boards and their corresponding user's guides and technical information, visit the Microchip web site at <a href="https://www.microchip.com/analogtools">www.microchip.com/analogtools</a>.

Some boards that are especially useful are:

 P/N SOIC8EV: 8-Pin SOIC/MSOP/TSSOP/DIP Evaluation Board

- P/N SOIC14EV: 14-Pin SOIC/TSSOP/DIP Evaluation Board
- MCP6XXX Amplifier Evaluation Board 1
- MCP6XXX Amplifier Evaluation Board 2
- MCP6XXX Amplifier Evaluation Board 3
- MCP6XXX Amplifier Evaluation Board 4
- · Active Filter Demo Board Kit

## 5.5 Application Notes

The following Microchip Application Notes are available on the Microchip web site at <a href="https://www.microchip.com/">www.microchip.com/</a> appnotes and are recommended as supplemental reference resources:

**ADN003:** "Select the Right Operational Amplifier for your Filtering Circuits", DS21821

**AN722:** "Operational Amplifier Topologies and DC Specifications", DS00722

**AN723:** "Operational Amplifier AC Specifications and Applications". DS00723

AN884: "Driving Capacitive Loads With Op Amps", DS00884

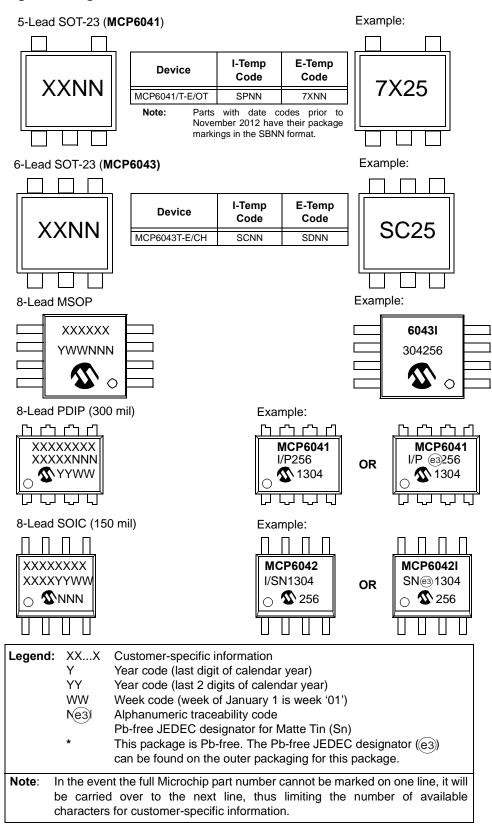
**AN990:** "Analog Sensor Conditioning Circuits – An Overview", DS00990

These application notes and others are listed in the design guide:

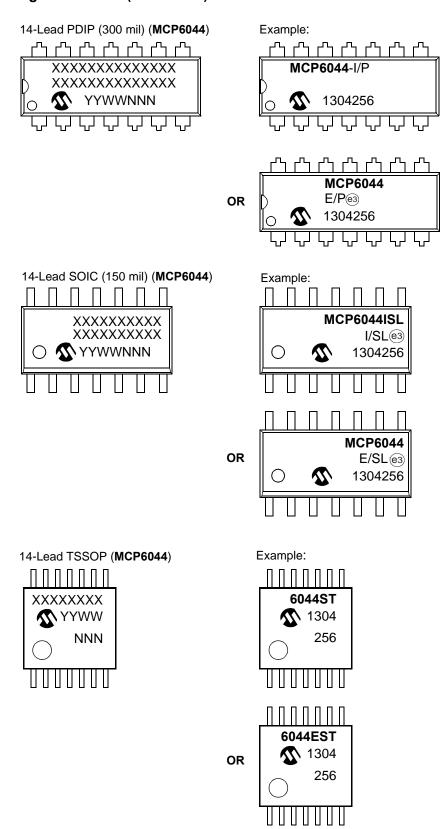
"Signal Chain Design Guide", DS21825

## 6.0 PACKAGING INFORMATION

## 6.1 Package Marking Information

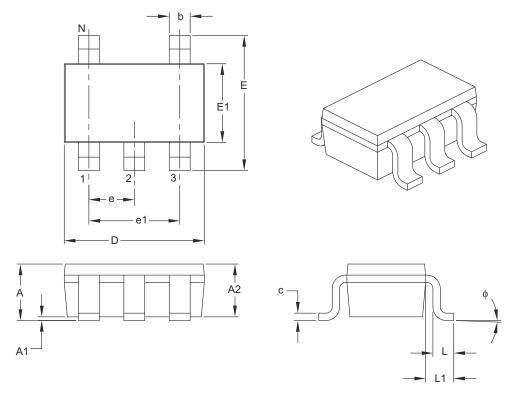


## **Package Marking Information (Continued)**



## 5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units			
Dimens	ion Limits	MIN	NOM	MAX
Number of Pins	N		5	
Lead Pitch	е		0.95 BSC	
Outside Lead Pitch	e1		1.90 BSC	
Overall Height	Α	0.90	_	1.45
Molded Package Thickness	A2	0.89	_	1.30
Standoff	A1	0.00	_	0.15
Overall Width	Е	2.20	_	3.20
Molded Package Width	E1	1.30	_	1.80
Overall Length	D	2.70	_	3.10
Foot Length	L	0.10	_	0.60
Footprint	L1	0.35	_	0.80
Foot Angle	ф	0°	_	30°
Lead Thickness	С	0.08	_	0.26
Lead Width	b	0.20	_	0.51

#### Notes:

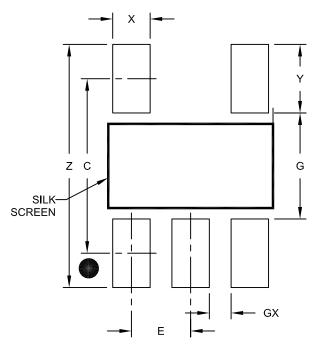
- 1. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.127 mm per side.
- 2. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-091B

## 5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



**RECOMMENDED LAND PATTERN** 

	MILLIMETERS			
Dimension	MIN	NOM	MAX	
Contact Pitch	Е		0.95 BSC	
Contact Pad Spacing	С		2.80	
Contact Pad Width (X5)	Х			0.60
Contact Pad Length (X5)	Υ			1.10
Distance Between Pads	G	1.70		
Distance Between Pads	GX	0.35		
Overall Width	Z			3.90

#### Notes:

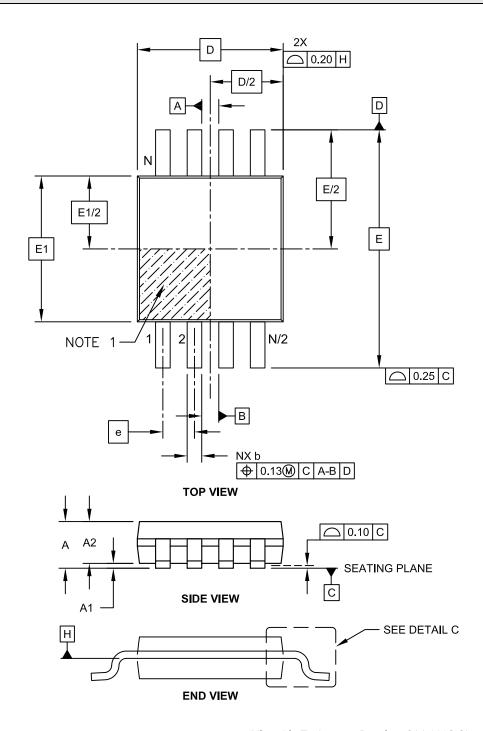
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2091A

## 8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

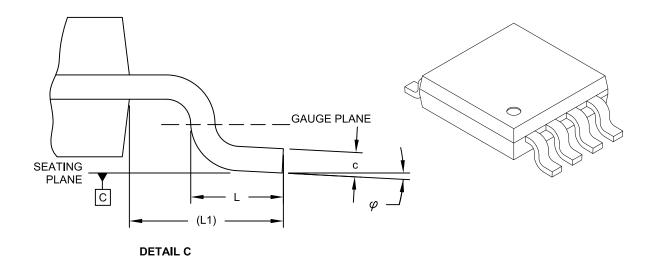
**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing C04-111C Sheet 1 of 2

## 8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



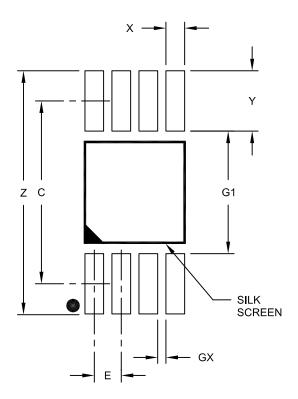
	MILLIMETERS				
Dimension	MIN	NOM	MAX		
Number of Pins	N		8		
Pitch	е		0.65 BSC		
Overall Height	Α	-	-	1.10	
Molded Package Thickness	A2	0.75	0.85	0.95	
Standoff	A1	0.00	-	0.15	
Overall Width	E	4.90 BSC			
Molded Package Width	E1		3.00 BSC		
Overall Length	D		3.00 BSC		
Foot Length	L	0.40	0.60	0.80	
Footprint	L1		0.95 REF		
Foot Angle	φ	0°	-	8°	
Lead Thickness	С	0.08	-	0.23	
Lead Width	b	0.22	-	0.40	

- Pin 1 visual index feature may vary, but must be located within the hatched area.
   Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 3. Dimensioning and tolerancing per ASME Y14.5M.
  - BSC: Basic Dimension. Theoretically exact value shown without tolerances.
  - REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-111C Sheet 2 of 2

## 8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

Units	l N	S		
Dimension Limits		NOM	MAX	
E		0.65 BSC		
С		4.40		
Z			5.85	
X1			0.45	
Y1			1.45	
G1	2.95			
GX	0.20			
	E C Z X1 Y1 G1	Limits   MIN   E   C   Z   X1   Y1   G1   2.95	Limits   MIN   NOM     E	

#### Notes:

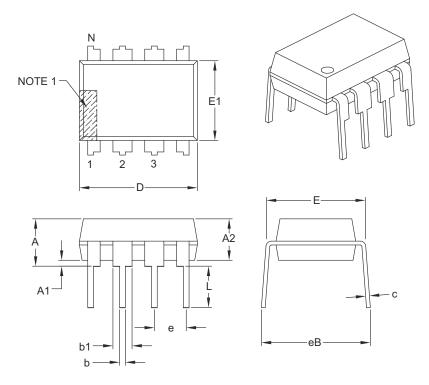
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2111A

## 8-Lead Plastic Dual In-Line (P) - 300 mil Body [PDIP]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units			
Dimension	n Limits	MIN	NOM	MAX
Number of Pins	N		8	
Pitch	е		.100 BSC	
Top to Seating Plane	Α	_	_	.210
Molded Package Thickness	A2	.115	.130	.195
Base to Seating Plane	A1	.015	_	_
Shoulder to Shoulder Width	Е	.290	.310	.325
Molded Package Width	E1	.240	.250	.280
Overall Length	D	.348	.365	.400
Tip to Seating Plane	L	.115	.130	.150
Lead Thickness	С	.008	.010	.015
Upper Lead Width	b1	.040	.060	.070
Lower Lead Width	b	.014	.018	.022
Overall Row Spacing §	eВ	_	_	.430

#### Notes:

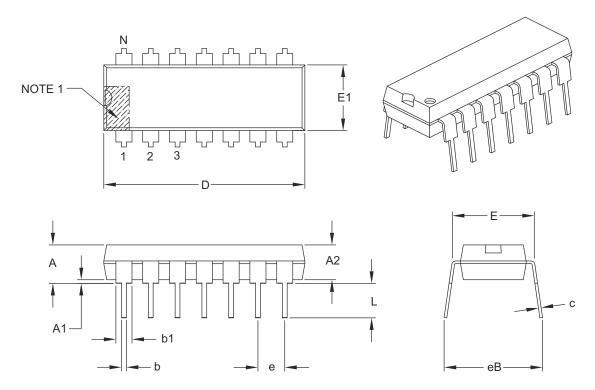
- 1. Pin 1 visual index feature may vary, but must be located with the hatched area.
- 2. § Significant Characteristic.
- 3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-018B

## 14-Lead Plastic Dual In-Line (P) - 300 mil Body [PDIP]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units			
Dimension	on Limits	MIN	NOM	MAX
Number of Pins	N		14	
Pitch	е		.100 BSC	
Top to Seating Plane	Α	_	_	.210
Molded Package Thickness	A2	.115	.130	.195
Base to Seating Plane	A1	.015	_	_
Shoulder to Shoulder Width	Е	.290	.310	.325
Molded Package Width	E1	.240	.250	.280
Overall Length	D	.735	.750	.775
Tip to Seating Plane	L	.115	.130	.150
Lead Thickness	С	.008	.010	.015
Upper Lead Width	b1	.045	.060	.070
Lower Lead Width	b	.014	.018	.022
Overall Row Spacing §	eB	-	_	.430

#### Notes:

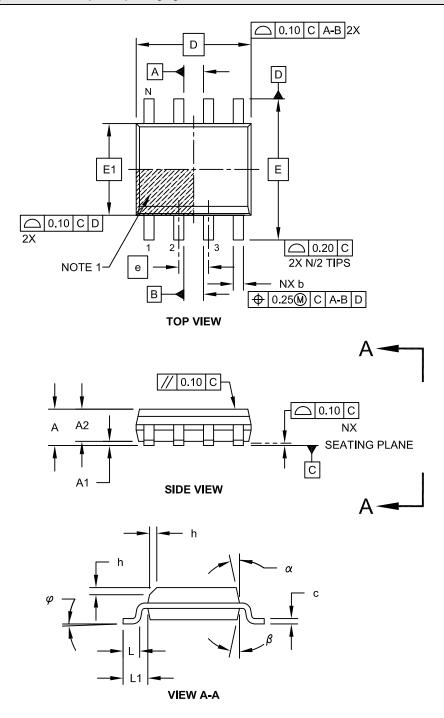
- 1. Pin 1 visual index feature may vary, but must be located with the hatched area.
- 2. § Significant Characteristic.
- 3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-005B

## 8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

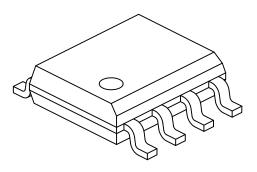
**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing No. C04-057C Sheet 1 of 2

## 8-Lead Plastic Small Outline (OA) - Narrow, 3.90 mm Body [SOIC]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Units		MILLIMETERS			
Dimension Limits		MIN	NOM	MAX	
Number of Pins	N		8		
Pitch	е		1.27 BSC		
Overall Height	Α	Ī	ı	1.75	
Molded Package Thickness	A2	1.25	ı	1	
Standoff §	A1	0.10	ı	0.25	
Overall Width	Е	6.00 BSC			
Molded Package Width	E1	3.90 BSC			
Overall Length	D	4.90 BSC			
Chamfer (Optional)	h	0.25 - 0.50			
Foot Length	L	0.40 - 1.27			
Footprint	L1	1.04 REF			
Foot Angle	φ	0° - 8°		8°	
Lead Thickness	С	0.17 - 0.25			
Lead Width	b	0.31	=	0.51	
Mold Draft Angle Top	α	5° - 15°			
Mold Draft Angle Bottom	β	5°	-	15°	

## Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. § Significant Characteristic
- 3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M

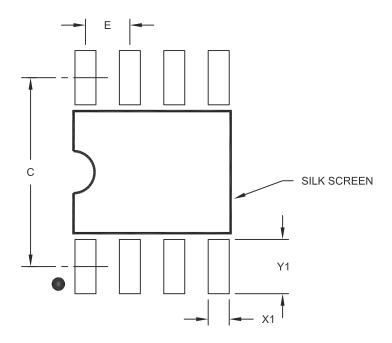
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-057C Sheet 2 of 2

## 8-Lead Plastic Small Outline (OA) - Narrow, 3.90 mm Body [SOIC]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	Units	MILLIMETERS		
Dimension	Dimension Limits		NOM	MAX
Contact Pitch	Е	1.27 BSC		
Contact Pad Spacing	С		5.40	
Contact Pad Width (X8)	X1			0.60
Contact Pad Length (X8)	Y1			1.55

## Notes:

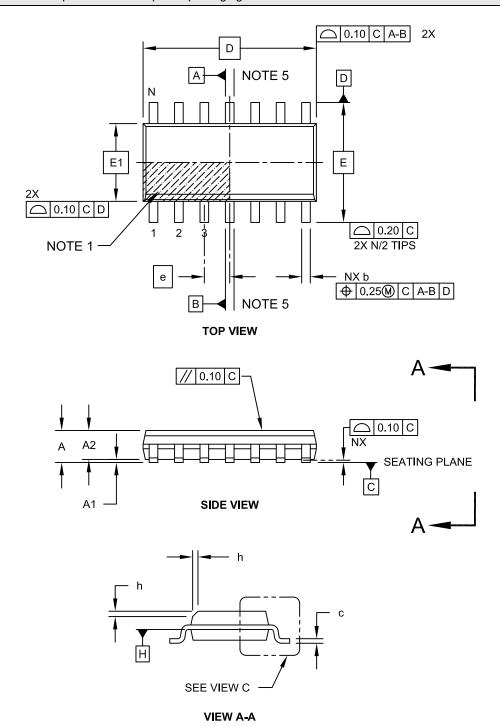
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2057A

## 14-Lead Plastic Small Outline (SL) - Narrow, 3.90 mm Body [SOIC]

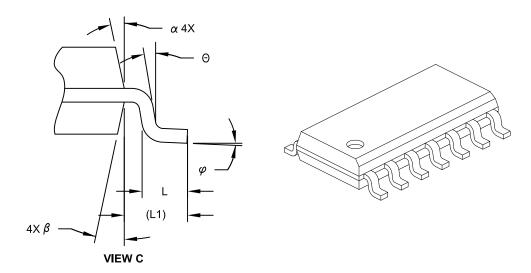
**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing No. C04-065C Sheet 1 of 2

## 14-Lead Plastic Small Outline (SL) - Narrow, 3.90 mm Body [SOIC]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units MILLIMETERS			S
Dimension Limits		MIN	NOM	MAX
Number of Pins	N	14		
Pitch	е		1.27 BSC	
Overall Height	Α	-	-	1.75
Molded Package Thickness	A2	1.25	-	-
Standoff §	A1	0.10 - 0.25		
Overall Width	Е	6.00 BSC		
Molded Package Width	E1	3.90 BSC		
Overall Length	D	8.65 BSC		
Chamfer (Optional)	h	0.25 - 0.50		
Foot Length	L	0.40 - 1.27		
Footprint	L1	1.04 REF		
Lead Angle	Θ	0°	-	-
Foot Angle	φ	0° - 8°		
Lead Thickness	С	0.10 - 0.25		
Lead Width	b	0.31	_	0.51
Mold Draft Angle Top	α	5°	-	15°
Mold Draft Angle Bottom	β	5° - 15°		

#### Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. § Significant Characteristic
- Dimension D does not include mold flash, protrusions or gate burrs, which shall not exceed 0.15 mm per end. Dimension E1 does not include interlead flash or protrusion, which shall not exceed 0.25 mm per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M

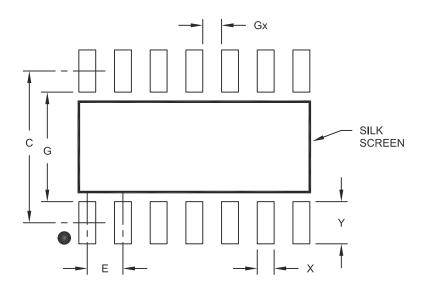
BSC: Basic Dimension. Theoretically exact value shown without tolerances. REF: Reference Dimension, usually without tolerance, for information purposes only.

5. Datums A & B to be determined at Datum H.

Microchip Technology Drawing No. C04-065C Sheet 2 of 2

14-Lead Plastic Small Outline (SL) - Narrow, 3.90 mm Body [SOIC]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	Units		MILLIMETERS		
Dimension	Dimension Limits		NOM	MAX	
Contact Pitch	E	1.27 BSC			
Contact Pad Spacing	С		5.40		
Contact Pad Width	Х			0.60	
Contact Pad Length	Υ	1.50		1.50	
Distance Between Pads	Gx	0.67			
Distance Between Pads	G	3.90			

#### Notes:

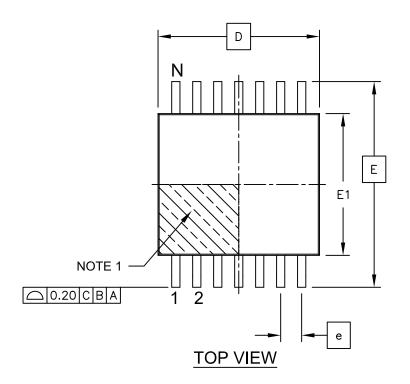
1. Dimensioning and tolerancing per ASME Y14.5M

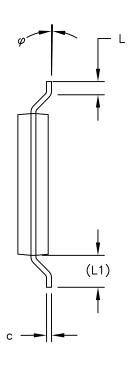
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

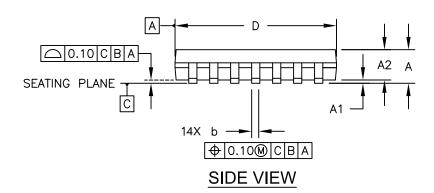
Microchip Technology Drawing No. C04-2065A

## 14-Lead Plastic Thin Shrink Small Outline (ST) - 4.4 mm Body [TSSOP]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



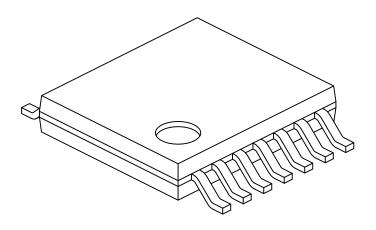




Microchip Technology Drawing C04-087C Sheet 1 of 2

## 14-Lead Plastic Thin Shrink Small Outline (ST) - 4.4 mm Body [TSSOP]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Number of Pins	N	14		
Pitch	е	0.65 BSC		
Overall Height	Α	1.20		
Molded Package Thickness	A2	0.80	1.00	1.05
Standoff	A1	0.05	-	0.15
Overall Width	E	6.40 BSC		
Molded Package Width	E1	4.30	4.40	4.50
Molded Package Length	D	4.90	5.00	5.10
Foot Length	L	0.45	0.60	0.75
Footprint	(L1)	1.00 REF		
Foot Angle	φ	0°	-	8°
Lead Thickness	С	0.09	-	0.20
Lead Width	b	0.19	-	0.30

#### Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 3. Dimensioning and tolerancing per ASME Y14.5M

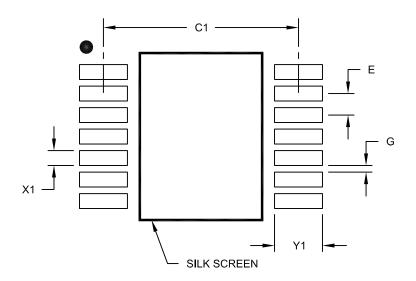
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-087C Sheet 2 of 2  $\,$ 

## 14-Lead Plastic Thin Shrink Small Outline (ST) - 4.4 mm Body [TSSOP]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



## RECOMMENDED LAND PATTERN

	Units			MILLIMETERS			
Dimension Limits		MIN	NOM	MAX			
Contact Pitch	Е		0.65 BSC				
Contact Pad Spacing	C1		5.90				
Contact Pad Width (X14)	X1			0.45			
Contact Pad Length (X14)	Y1			1.45			
Distance Between Pads	G	0.20					

#### Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2087A

## APPENDIX A: REVISION HISTORY

## **Revision D (March 2013)**

The following is the list of modifications:

- Updated the boards list in Section 5.4 "Analog Demonstration and Evaluation Boards".
- Removed the Mindi™ Circuit Designer & Simulator section.
- Updated the E-Temp Code value for the 5-Lead SOT-23 package in Section 6.0 "Packaging Information".

## **Revision C (February 2008)**

The following is the list of modifications:

- 1. Updated Figure 2-4 and Figure 2-5.
- 2. Updated trademark and Sales listing pages.
- 3. Expanded this op amp family:
- Added the SOT-23-6 package for the MCP6043 op amp with Chip Select.
- 5. Added Extended Temperature (-40°C to +125°C) parts.
- 6. Expanded Analog Input Absolute Max Voltage Range (applies retroactively).
- 7. Expanded operating V<sub>DD</sub> to a maximum of 6.0V.
- Section 1.0 "Electrical Characteristics" updated.
- Section 2.0 "Typical Performance Curves" updated.
- 10. Section 3.0 "Pin Descriptions" added.
- 11. Section 4.0 "Applications Information" added.
- 12. Added Section 4.7 "Unused Op Amps".
- 13. Updated input stage explanation.
- 14. Section 5.0 "Design Aids" updated.
- 15. Section 6.0 "Packaging Information" updated.
- 16. Added SOT-23-6 package.
- 17. Corrected package marking information.
- 18. Appendix A: "Revision History" added.

## Revision B (June 2002)

The following is the list of modifications.

• Undocumented changes.

## **Revision A (August 2001)**

· Original data sheet release.

# MCP6041/2/3/4

**NOTES:** 

## PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO. X /XX			Examples:			
•	erature Package nge	a) b)	MCP6041-I/P: MCP6041T-E/OT:	Industrial Temperature, 8LD PDIP package. Tape and Reel, Extended Temperature, 5LD SOT-23 package.		
Device:	MCP6041: Single Op Amp MCP6041T Single Op Amp (Tape and Reel for SOT-23, SOIC, MSOP) Dual Op Amp MCP6042T Dual Op Amp (Tape and Reel for SOIC and MSOP) MCP6043 Single Op Amp w/ Chip Select MCP6043T Single Op Amp w/ Chip Select (Tape and Reel for SOT-23, SOIC, MSOP) MCP6044 Quad Op Amp MCP6044T Quad Op Amp (Tape and Reel for SOIC and TSSOP)	a) b) a) b)	MCP6042-I/SN: MCP6042T-E/MS  MCP6043-I/P: MCP6043T-E/CH: MCP6044-I/SL:	Industrial Temperature, 8LD SOIC package. Tape and Reel, Extended Temperature, 8LD MSOP package. Industrial Temperature, 8LD PDIP package. Tape and Reel, Extended Temperature, 6LD SOT-23 package. Industrial Temperature,		
Temperature Range:	I = -40°C to +85°C E = -40°C to +125°C	b)	MCP6044T-E/ST:	14LD SOIC package. Tape and Reel, Extended Temperature, 14LD TSSOP package.		
Package:	CH = Plastic Small Outline Transistor (SOT-23), 6-lead (Tape and Reel - MCP6043 only)  MS = Plastic Micro Small Outline (MSOP), 8-lead OT = Plastic Small Outline Transistor (SOT-23), 5-lead (Tape and Reel - MCP6041 only)  P = Plastic DIP (300 mil Body), 8-lead, 14-lead SL = Plastic SOIC (150 mil Body), 14-lead SN = Plastic SOIC (150 mil Body), 8-lead ST = Plastic TSSOP (4.4 mm Body), 14-lead					

# MCP6041/2/3/4

NOTES:

#### Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the
  intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as "unbreakable."

Code protection is constantly evolving. We at Microchip are committed to continuously improving the code protection features of our products. Attempts to break Microchip's code protection feature may be a violation of the Digital Millennium Copyright Act. If such acts allow unauthorized access to your software or other copyrighted work, you may have a right to sue for relief under that Act.

Information contained in this publication regarding device applications and the like is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, MERCHANTABILITY OR FITNESS FOR PURPOSE. Microchip disclaims all liability arising from this information and its use. Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights.

# QUALITY MANAGEMENT SYSTEM CERTIFIED BY DNV = ISO/TS 16949=

#### **Trademarks**

The Microchip name and logo, the Microchip logo, dsPIC, FlashFlex, KEELOQ, KEELOQ logo, MPLAB, PIC, PICmicro, PICSTART, PIC<sup>32</sup> logo, rfPIC, SST, SST Logo, SuperFlash and UNI/O are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

FilterLab, Hampshire, HI-TECH C, Linear Active Thermistor, MTP, SEEVAL and The Embedded Control Solutions Company are registered trademarks of Microchip Technology Incorporated in the U.S.A.

Silicon Storage Technology is a registered trademark of Microchip Technology Inc. in other countries.

Analog-for-the-Digital Age, Application Maestro, BodyCom, chipKIT, chipKIT logo, CodeGuard, dsPICDEM, dsPICDEM.net, dsPICworks, dsSPEAK, ECAN, ECONOMONITOR, FanSense, HI-TIDE, In-Circuit Serial Programming, ICSP, Mindi, MiWi, MPASM, MPF, MPLAB Certified logo, MPLIB, MPLINK, mTouch, Omniscient Code Generation, PICC, PICC-18, PICDEM, PICDEM.net, PICkit, PICtail, REAL ICE, rfLAB, Select Mode, SQI, Serial Quad I/O, Total Endurance, TSHARC, UniWinDriver, WiperLock, ZENA and Z-Scale are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

GestIC and ULPP are registered trademarks of Microchip Technology Germany II GmbH & Co. & KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

© 2001-2013, Microchip Technology Incorporated, Printed in the U.S.A., All Rights Reserved.

Printed on recycled paper.

ISBN: 978-1-62077-042-9

Microchip received ISO/TS-16949:2009 certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona; Gresham, Oregon and design centers in California and India. The Company's quality system processes and procedures are for its PIC® MCUs and dsPIC® DSCs, KEELOQ® code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.



## **Worldwide Sales and Service**

#### **AMERICAS**

Corporate Office

2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200

Fax: 480-792-7277 Technical Support:

http://www.microchip.com/

support

Web Address: www.microchip.com

Atlanta

Duluth, GA

Tel: 678-957-9614 Fax: 678-957-1455

**Boston** 

Westborough, MA Tel: 774-760-0087 Fax: 774-760-0088

Chicago Itasca, IL

Tel: 630-285-0071 Fax: 630-285-0075

Cleveland

Independence, OH Tel: 216-447-0464 Fax: 216-447-0643

Dallas

Addison, TX Tel: 972-818-7423 Fax: 972-818-2924

Detroit

Farmington Hills, MI Tel: 248-538-2250 Fax: 248-538-2260

Indianapolis

Noblesville, IN Tel: 317-773-8323 Fax: 317-773-5453

Los Angeles

Mission Viejo, CA Tel: 949-462-9523 Fax: 949-462-9608

Santa Clara

Santa Clara, CA Tel: 408-961-6444 Fax: 408-961-6445

Toronto

Mississauga, Ontario,

Canada

Tel: 905-673-0699 Fax: 905-673-6509

#### ASIA/PACIFIC

**Asia Pacific Office** 

Suites 3707-14, 37th Floor Tower 6, The Gateway Harbour City, Kowloon Hong Kong

Tel: 852-2401-1200 Fax: 852-2401-3431

**Australia - Sydney** Tel: 61-2-9868-6733

Fax: 61-2-9868-6755

China - Beijing

Tel: 86-10-8569-7000 Fax: 86-10-8528-2104

China - Chengdu

Tel: 86-28-8665-5511 Fax: 86-28-8665-7889

China - Chongqing

Tel: 86-23-8980-9588 Fax: 86-23-8980-9500

China - Hangzhou

Tel: 86-571-2819-3187 Fax: 86-571-2819-3189

China - Hong Kong SAR

Tel: 852-2943-5100 Fax: 852-2401-3431

China - Nanjing

Tel: 86-25-8473-2460 Fax: 86-25-8473-2470

China - Qingdao

Tel: 86-532-8502-7355 Fax: 86-532-8502-7205

China - Shanghai

Tel: 86-21-5407-5533 Fax: 86-21-5407-5066

China - Shenyang

Tel: 86-24-2334-2829 Fax: 86-24-2334-2393

China - Shenzhen

Tel: 86-755-8864-2200 Fax: 86-755-8203-1760

China - Wuhan

Tel: 86-27-5980-5300 Fax: 86-27-5980-5118

China - Xian

Tel: 86-29-8833-7252 Fax: 86-29-8833-7256

China - Xiamen

Tel: 86-592-2388138 Fax: 86-592-2388130

China - Zhuhai

Tel: 86-756-3210040 Fax: 86-756-3210049

#### ASIA/PACIFIC

India - Bangalore

Tel: 91-80-3090-4444 Fax: 91-80-3090-4123

India - New Delhi

Tel: 91-11-4160-8631 Fax: 91-11-4160-8632

India - Pune

Tel: 91-20-2566-1512 Fax: 91-20-2566-1513

Japan - Osaka

Tel: 81-6-6152-7160 Fax: 81-6-6152-9310

Japan - Tokyo

Tel: 81-3-6880- 3770 Fax: 81-3-6880-3771

Korea - Daegu

Tel: 82-53-744-4301 Fax: 82-53-744-4302

Korea - Seoul

Tel: 82-2-554-7200 Fax: 82-2-558-5932 or 82-2-558-5934

Malaysia - Kuala Lumpur

Tel: 60-3-6201-9857 Fax: 60-3-6201-9859

Malaysia - Penang

Tel: 60-4-227-8870 Fax: 60-4-227-4068

Philippines - Manila

Tel: 63-2-634-9065 Fax: 63-2-634-9069

Singapore

Tel: 65-6334-8870 Fax: 65-6334-8850

Taiwan - Hsin Chu

Tel: 886-3-5778-366 Fax: 886-3-5770-955

Taiwan - Kaohsiung

Tel: 886-7-213-7828 Fax: 886-7-330-9305

Taiwan - Taipei

Tel: 886-2-2508-8600 Fax: 886-2-2508-0102

Thailand - Bangkok

Tel: 66-2-694-1351 Fax: 66-2-694-1350

#### **EUROPE**

Austria - Wels

Tel: 43-7242-2244-39 Fax: 43-7242-2244-393

Denmark - Copenhagen

Tel: 45-4450-2828 Fax: 45-4485-2829

France - Paris

Tel: 33-1-69-53-63-20 Fax: 33-1-69-30-90-79

**Germany - Munich** 

Tel: 49-89-627-144-0 Fax: 49-89-627-144-44

Italy - Milan

Tel: 39-0331-742611 Fax: 39-0331-466781

Netherlands - Drunen

Tel: 31-416-690399 Fax: 31-416-690340

Spain - Madrid

Tel: 34-91-708-08-90 Fax: 34-91-708-08-91

**UK - Wokingham** Tel: 44-118-921-5869 Fax: 44-118-921-5820

11/29/12